

FDP2670/FDB2670

200V N-Channel PowerTrench[®] MOSFET

General Description

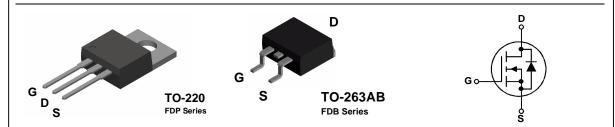
This N-Channel MOSFET has been designed specifically for switching on the primary side in the isolated DC/DC converter application. Any application requiring a 200V MOSFETs with low on-resistance and fast switching will benefit.

These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $\mathsf{RDS}_{(\mathsf{ON})}$ specifications.

The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

Features

- 19 A, 200 V. $R_{\text{DS(ON)}}$ = 130 m Ω @ V_{GS} = 10 V
- Low gate charge (27 nC typical)
- Fast switching speed
- + High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- High power and current handling capability



Absolute Maximum Ratings T_A=25°C unless otherwise noted

| Symbol | Parameter | | Ratings | Units |
|-----------------------------------|--|----------|-------------|-------|
| V _{DSS} | Drain-Source Voltage | | 200 | V |
| V _{GSS} | Gate-Source Voltage | | ± 20 | V |
| ID | Drain Current – Continuous | (Note 1) | 19 | А |
| | – Pulsed | (Note 1) | 40 | A |
| PD | Total Power Dissipation @ T _c = 25°C | ; | 93 | W |
| | Derate above 25°C | | 0.63 | W°/C |
| dv/dt | Peak Diode Recovery dv/dt | (Note 3) | 3.2 | V/ns |
| T _J , T _{STG} | Operating and Storage Junction Temperature Range | | -65 to +175 | °C |

Thermal Characteristics

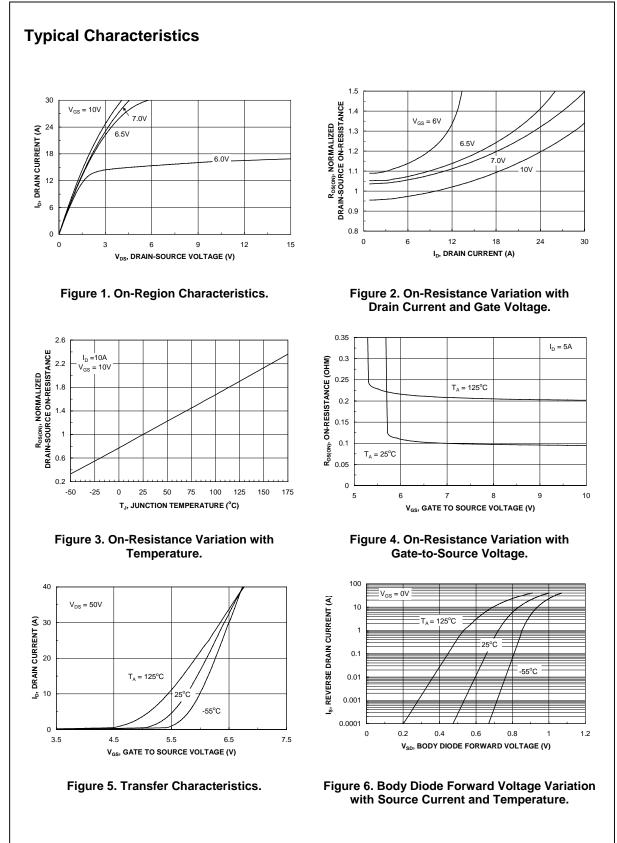
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case | 1.6 | °C/W |
|-----------------------|---|------|------|
| $R_{	extsf{	heta}JA}$ | Thermal Resistance, Junction-to-Ambient | 62.5 | °C/W |

Package Marking and Ordering Information

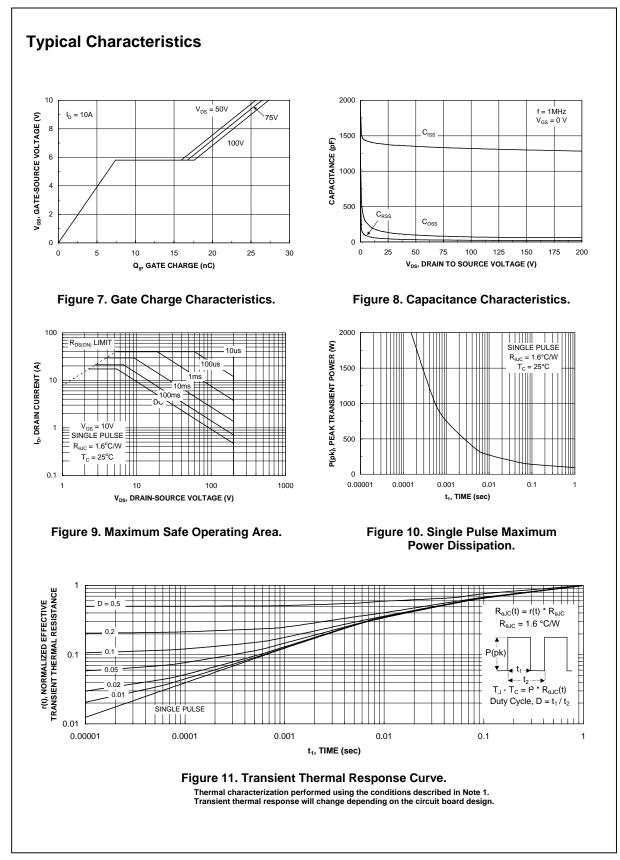
| Device Marking | Device | Reel Size | Tape width | Quantity | |
|----------------|---------|-----------|------------|-----------|--|
| FDB2670 | FDB2670 | 13" | 24mm | 800 units | |
| FDP2670 | FDP2670 | Tube | n/a | 45 units | |

©2001 Fairchild Semiconductor Corporation

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|-------------------------------------|---|--|-----|-----------|------------|-------|
| Drain-So | burce Avalanche Ratings (Note | | | | | |
| N _{DSS} | Single Pulse Drain-Source Avalanche Energy | $V_{DD} = 100 \text{ V}, \qquad I_D = 10 \text{ A}$ | | | 375 | mJ |
| AR | Maximum Drain-Source Avalanche Current | | | | 10 | А |
| Off Char | acteristics | 1 | | | | |
| 3V _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 V, I_{D} = 250 \mu A$ | 200 | | | V |
| Δ <u>BVdss</u> ΔTj | Breakdown Voltage Temperature Coefficient | $I_D = 250 \mu\text{A}$, Referenced to 25°C | | 241 | | mV/°C |
| DSS | Zero Gate Voltage Drain Current | $V_{DS} = 160 \text{ V}, V_{GS} = 0 \text{ V}$ | | | 1 | μA |
| GSSF | Gate-Body Leakage, Forward | $V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | 100 | nA |
| GSSR | Gate-Body Leakage, Reverse | $V_{GS} = -20 \text{ V} \qquad V_{DS} = 0 \text{ V}$ | | | -100 | nA |
| On Char | acteristics (Note 2) | • | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = 250 \ \mu A$ | 2 | 4 | 4.5 | V |
| $\Delta V_{GS(th)}$ ΔT_J | Gate Threshold Voltage Temperature Coefficient | $I_D = 250 \mu$ A, Referenced to 25°C | | -9 | | mV/°C |
| R _{DS(on)} | Static Drain–Source On–Resistance | $V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}, T_J = 125^{\circ}\text{C}$ | | 98 205 | 130 285 | mΩ |
| D(on) | On–State Drain Current | $V_{GS} = 10 \text{ V}, V_{DS} = 10 \text{ V}$ | 20 | | | А |
| g Fs | Forward Transconductance | $V_{\rm DS} = 10 \text{ V}, \qquad I_{\rm D} = 10 \text{ A}$ | - | 24 | | S |
| - | Characteristics | | | | | |
| C _{iss} | Input Capacitance | $V_{DS} = 100 V$, $V_{GS} = 0 V$, | 1 | 1320 | | pF |
| Coss | Output Capacitance | f = 1.0 MHz | 1 | 71 | | pF |
| Crss | Reverse Transfer Capacitance | 1 | | 24 | | pF |
| | · | | | | | P . |
| | g Characteristics (Note 2) | V 400 V 1 4 4 | 1 | 14 | 25 | 20 |
| d(on) | Turn–On Delay Time Turn–On Rise Time | | | 5 | 10 | ns |
| r | | $V_{\rm GS} = 10^{\circ}$, $V_{\rm GEN} = 0.22$ | | 26 | 41 | ns |
| d(off) | Turn–Off Delay Time Turn–Off Fall Time | - | | - | | ns |
| f | | | | 23 | 37 | ns |
| ב ל ^מ | Total Gate Charge | $V_{DS} = 100 \text{ V}, \qquad I_D = 10 \text{ A}, V_{GS} = 10 \text{ V}$ | | 27 7 | 38 | nC |
| כ ^{gs} | Gate-Source Charge | | | | | nC |
| | Gate-Drain Charge | | | 10 | | nC |
| | ource Diode Characteristics | | 1 | 1 | 40 | • |
| S | Maximum Continuous Drain–Source Drain–Source Diode Forward | Diode Forward Current | | | 19 | A |
| V _{SD} | Voltage | $V_{GS} = 0 V$, $I_{S} = 10 A$ (Note 2) | | 0.8 | 1.3 | V |
| Pulse Test: Pu | ntinuous current based on maximum allowable jun Ilse Width < 300μs, Duty Cycle < 2.0% ≤ 100A/μs, V _{DD} ≤ BV _{DSS} , Starting T _J = 25°C | ction temperature. | | | | |



FDP2670/FDB2670 Rev C1(W)



FDP2670/FDB2670 Rev C1(W)

TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACExTM BottomlessTM CoolFETTM CROSSVOLTTM DenseTrenchTM DOMETM EcoSPARKTM E²CMOSTM EnSignaTM FACTTM FACT Quiet SeriesTM FAST $^{\textcircled{(0)}}$ OPTOLFASTrTMOPTOFFRFETTMPACMAGlobalOptoisolatorTMPOPTMGTOTMPower2HiSeCTMPower7ISOPLANARTMQFETTMLittleFETTMQSTMMicroFETTMQT OptMicroPakTMQuiet SMICROWIRETMSILENT

OPTOLOGIC[™] OPTOPLANAR[™] PACMAN[™] POP[™] Power247[™] PowerTrench[®] QFET[™] QS[™] QT Optoelectronics[™] Quiet Series[™] SILENT SWITCHER[®] SMART START[™] VCX[™] STAR*POWER[™] SuperSOT[™]-3 SuperSOT[™]-6 SuperSOT[™]-6 SuperSOT[™]-8 SyncFET[™] TinyLogic[™] TruTranslation[™] UHC[™] UltraFET[®]

STAR*POWER is used under license

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user. 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

| Datasheet Identification | Product Status | Definition |
|--------------------------|---------------------------|---|
| Advance Information | Formative or In Design | This datasheet contains the design specifications for product development. Specifications may change in any manner without notice. |
| Preliminary | First Production | This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design. |
| No Identification Needed | Full Production | This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design. |
| Obsolete | Not In Production | This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only. |
| | - | Rev. H4 |